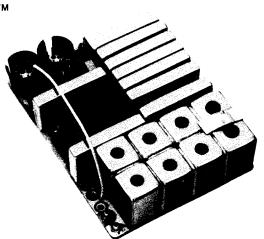


406-470 MHz RECEIVER

ER-60-A FOR PE MODELS AND Porta-Mobil II™



SPECIFICATIONS *

Type Number	ER-60-A
Audio Output (EIA)	500 milliwatts at less than 5% distortion
Channel Spacing	25 kHz
Sensitivity 12-dB SINAD (EIA Method) 20-dB Quieting Method	0.35 μV 0.5 μV
Selectivity EIA Two-Signal	-65 dB at ± 25 kHz
20-dB Quieting Method	-90 dB at ±25 kHz
Spurious Response	-60 dB
Intermodulation (EIA)	-65 dB
Audio Response	+2 and -10 dB of a standard 6-dB per octave deemphasis curve from 300 to 3000 Hz (1000-Hz reference)
Modulation Acceptance	±7.0 kHz
Squelch Sensitivity Critical Squelch Maximum Squelch	0.20 μV Greater than 20-dB Quieting
Maximum Frequency Spacing Frequency Range	No Degradation1 dB Degradation(Sensitivity)(Sensitivity)
406-420 MHz 450-460 MHz 460-470 MHz	1.62 MHz 3.25 MHz 1.80 MHz 3.60 MHz 1.84 MHz 3.68 MHz

these specifications are intended primarily for the use of the serviceman. Refer to the appropriate Specification Sheet for the complete specifications.

GENERAL (%) ELECTRIC

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---WARNING---

No one should be permitted to handle any portion of the equipment that is supplied with high voltage; or to connect any external apparatus to the units while the units are supplied with power. KEEP AWAY FROM LIVE CIRCUITS.

DESCRIPTION

Receiver Models 4ER60A10-13 are single conversion, superheterodyne FM receivers for operation on the 406-420 and 450-470 MHz bands. The complete receiver mounts on a single printed wiring board, and utilizes both discrete components and Integrated Circuit modules. The application of each model receiver is shown in the following Chart:

Model No.	Freq. Range	Number of Freqs.	Tone Option		
4ER60A10 4ER60A11 4ER60A12 4ER60A13	406-420 MHz 450-470 MHz 406-420 MHz 450-470 MHz		Chan.Gd. Chan.Gd.		

References to symbol numbers mentioned in the following text are found on the Schematic Diagram, Outline Diagram and Parts List (see Table of Contents). The typical circuit diagrams used in the text are representative of the circuits used in the Integrated Circuit modules. A block diagram of the receiver is shown in Figure 1. Supply voltage for the receiver includes a continuous regulated 5.4 Volts for the compensator module, a continuous 7.5 Volts for the squelch module, and a switched 7.5 Volts for the remaining receiver stages.

CIRCUIT ANALYSIS

OSCILLATOR MODULE

Oscillator Model 4EG28A12 (406-420 MHz) and 4EG28A13 (450-470 MHz) consists of a crystal-controlled Colpitts oscillator similar to the Oscillator module used in the transmitter (see Figure 2). The entire oscillator is contained in a metal can with the receiver operating frequency printed on the top. The crystal frequency ranges from 19.33 to 22.38 MHz, and the crystal frequency is multiplied 21 times.

The oscillator frequency is temperature compensated to provide instant frequency compensation, with a frequency stability of $\pm.0002\%$ from 0°C to +55°C and $\pm.0005\%$ from -30°C to +60°C. The temperature compensation network is contained in Compensator Module A313.

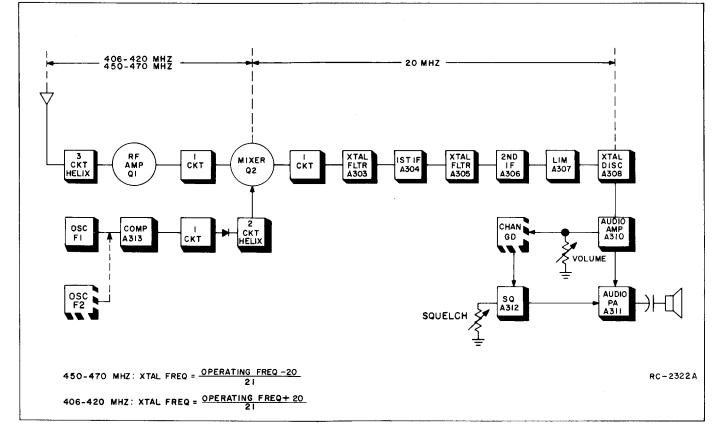


Figure 1 - Receiver Block Diagram

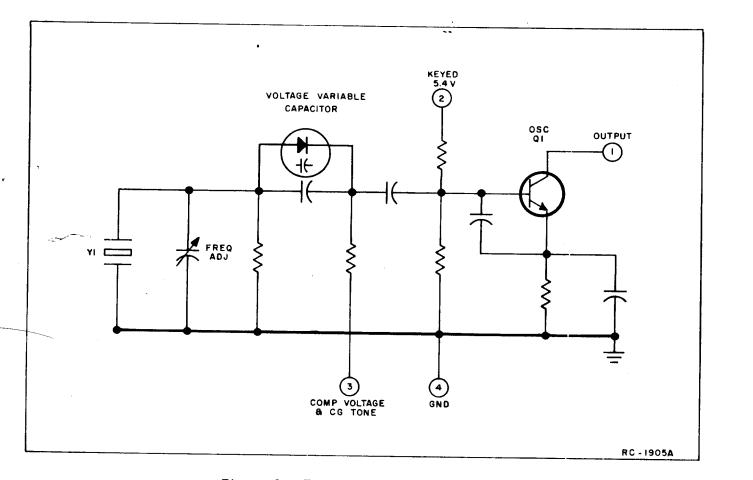


Figure 2 - Typical Oscillator Circuit

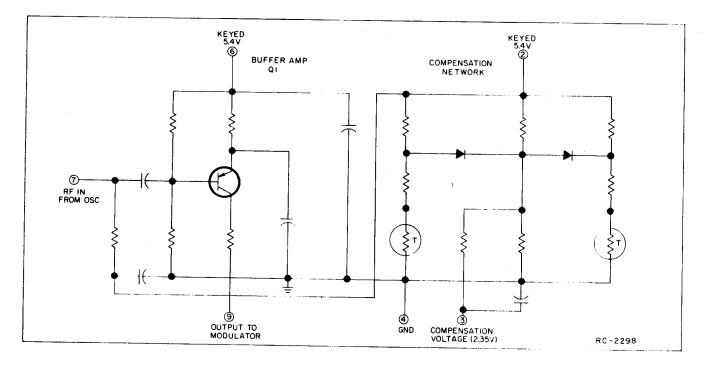


Figure 3 - Typical Compensator Circuit

2

In single frequency receivers, a jumper from H10 to H11 on System Board A702 connects the oscillator module to the continuous 5.4 volt supply voltage. The oscillator output is applied to Compensator A313.

In two-frequency receivers, an additional oscillator module is mounted on the receiver board. The single-frequency supply jumper is removed, and the proper frequency is selected by connecting the 5.4 Volts to the selected oscillator module through frequency selector switch Sl on the control unit.

- NOTE -

All oscillator modules are individually compensated at the factory and cannot be repaired in the field. Any attempt to remove the oscillator cover will void the warranty.

COMPENSATOR A313

Compensator module A313 contains a buffer-amplifier stage and the temperature compensation network for the oscillator. (see Figure 3)

RF from the oscillator is coupled through a DC blocking capacitor to the base of Ql. The output of Ql connects to multiplier coil Ll on the Multiplier assembly.

In the compensation network, the regulated 5.4 Volts at Pin 2 is applied to a thermistor-compensated voltage divider. The output at Pin 3 (2.35 Volts measured with a VTVM) is applied to Pin 3 and to the varactor in the Oscillator module. At temperatures below -10°C, the compensated voltage increases to maintain the proper voltage on the oscillator voltage-variable capacitor.

- SERVICE NOTE ----

An abnormally low VTVM reading (or no reading) at Pin 3 may indicate a short or leakage path in the oscillator. This can be checked by unsoldering Pin 2, raising it off of the printed board and taking another reading. If this reading is normal, the problem is in the Oscillator module. If the reading remains low (or zero), the problem is in the Compensator.

FRONT END A316/A317

The receiver Front End consists of three tuned helical resonators and an RF amplifier stage. The RF signal from the antenna is coupled through RF cable W301 to a tap on L11/L16. The tap is positioned to provide the proper impedance match to the antenna. RF energy is coupled to the third coil (L13/L18) through openings in the sides of the cans. RF is then coupled from a tap on L13/L18 through C8 to the base of RF amplifier Q1. The output of Q1 is developed across tuned circuit C9/C10 and L3, and is applied to the base of the mixer.

MULTIPLIER & MIXER

The output of the Compensator module is applied to L1 in the Multiplier assembly. L1 is tuned to three times the crystal frequency and is metered at the Mult Test Point (H8) on the receiver board. The output of L1 is applied to the anode of multiplier diode CR1. The two helical resonators following CR1 are tuned to seven times the first multiplier frequency for a total multiplication of 21 times. The output of the helical resonators is directcoupled to the emitter of the mixer transistor. In 406-420 MHz receivers, a high side injection frequency is used. In 450-470 MHz receivers, a low side injection frequency is used.

The RF signal from the RF amplifier is applied to the base of mixer Q1 and the high or low side injection voltage from the multiplier assembly is applied to the emitter. The resultant 20-MHz IF frequency is coupled through the mixer collector tank (L2 & C6) to Crystal Filter A303. The collector tank also provides impedance matching to the crystal filter.

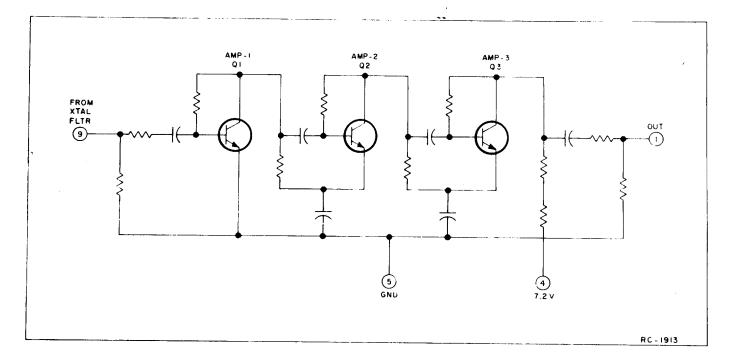
CRYSTAL FILTERS A303 & A305

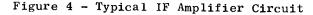
Filter A303 follows the Multiplier-Mixer stage, and its output is applied to the 1st IF amplifier module. Filter A305 follows the IF Amplifier module. The two Crystal Filter provide the major selectivity for the receiver. A303 provides a minimum of 40-dB stop-band attenuation, while A305 provides a minimum of 20-dB stop-band attenuation.

IF AMPS A304 & A306

An IF Amplifier module follows each of the crystal filters, and contain the resistor-matching networks for the filters. A typical IF amplifier circuit is shown in Figure 4.

Each of the IF Amplifier modules consists of three R-C coupled amplifier stages that the DC series-connected for reduced drain. The two IF modules provide a total gain of approximately 85 dB.





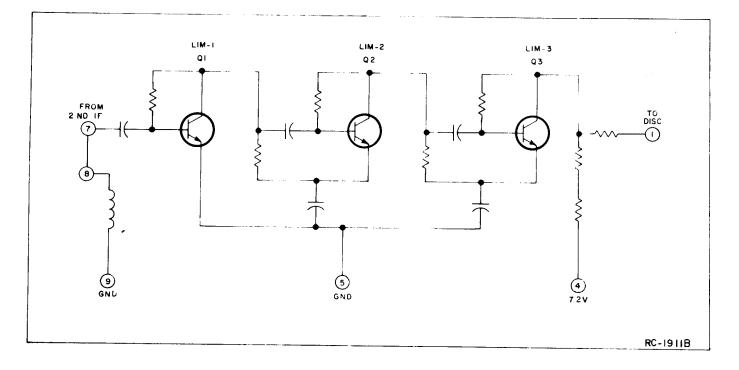


Figure 5 - Typical Limiter Circuit

LIMITER A307 & DISCRIMINATOR A308

criminator. A typical Limiter circuit is

Limiter A307 consists of three R-C coupled limiter stages that are DC series connected for reduced drain. The Limiter module also provides some gain. The output of the Limiter is applied to the dis-

shown in Figure 5.

The receiver uses a 20 MHz, fixed-tuned crystal discriminator (A308) to recover the audio from the IF signal. The Discriminator output is applied to the Audio Amplifier module.



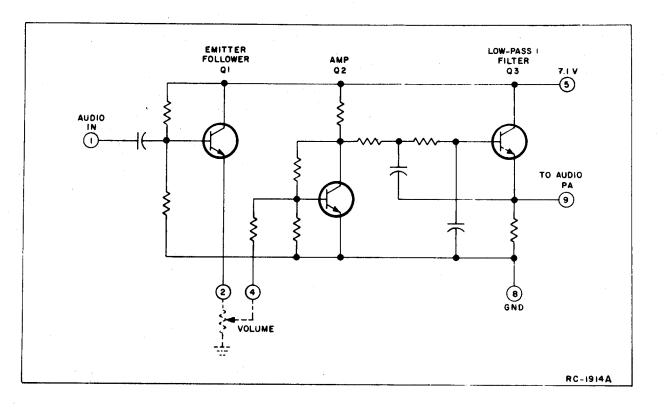


Figure 6 - Typical Audio Amplifier Circuit

AUDIO AMPLIFIER A310

Audio and noise from the discriminator is applied to Audio Amplifier module A310. A typical audio amplifier circuit is shown in Figure 6.

Audio and noise is applied to the base of Q1. This stage operates as an emitterfollower for matching the impedance of the discriminator to the amplifier stage (Q2) and the VOLUME control. The output of Q1 connects from Pin 2 to the base of amplifier Q2 (Pin 4) through the VOLUME control. The output of Q1 is also applied to the input of the Squelch module.

Following amplifier Q2 is an active lowpass filter (Q3). Audio from the filter is connected from Pin 9 to the Audio PA module. In Audio Amplifier module A310, an active high-pass filter is added in series with the low-pass filter to provide the required tone frequency roll-off.

AUDIO PA A311

When the receiver is quieted by a signal, audio from the active filter is connected to Pin 1 of Audio PA module A311, and then to the base of amplifier Q1. Q1 feeds the audio signal to the base of Q2, which drives PA transistors Q4 and Q5. A typical audio PA circuit is shown in Figure 7.

PA transistors Q4 and Q5 operate as complementary emitter-followers, providing a 500 milliwatt output into a 8-ohm load. Audio from Pin 9 is coupled through capacitor C302 on the receiver board to the loudspeaker.

SQUELCH A312

Noise from Audio Amplifier A310 operates the squelch circuit. A typical squelch circuit is shown in Figure 8.

When no carrier is present in the receiver, the noise output of active highpass filter Q1 is coupled to the base of noise amplifier Q2 through SQUELCH control R708. R708 controls the gain of the noise amplifier.

The output of noise amplifier Q2 is detected by diodes CR1 and CR2, and the resultant positive voltage turns off the PNP squelch switch Q3. In standard radios, the emitter of Q3 is connected to +7 Volts by means of a jumper from H1 to H2. When noise turns off Q3, its collector drops to ground potential. As the collector of Q3 is connected to the base of amplifier Q1 in the Audio PA module, turning off Q3 also turns off Q1, keeping the audio PA turned off.

5

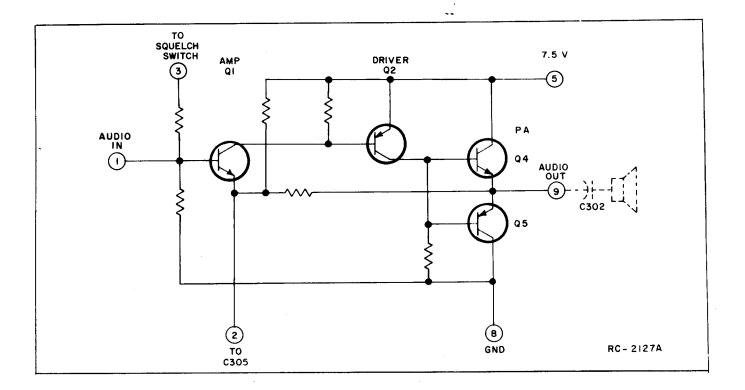


Figure 7 - Typical Audio PA Circuit

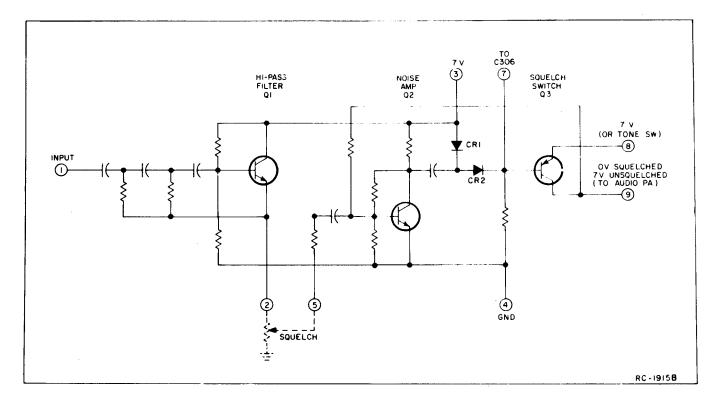


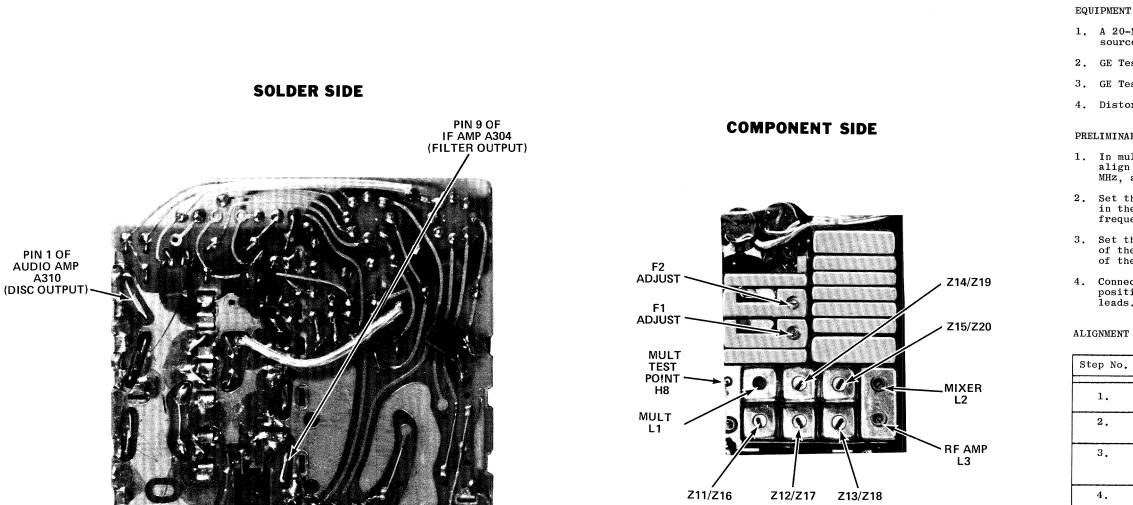
Figure 8 - Typical Squelch Circuit

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When the receiver is quieted by a signal, squelch switch Q3 turns on. This applies +7 Volts to the base of amplifier Q1 in the Audio PA module, turning the Audio PA circuit on so that sound is heard at the speaker.

In tone decoder applications, the 7volt jumper from H1 to H2 is removed. The emitter of squelch switch Q3 is connected to 7.5 Volts by a DC switch on the decoder · board.

An RF adaptor cable is available for connecting the receiver to a signal generator. Connecting the RF adaptor cable to J702 opens a set of contacts on the antenna strip line assembly. This disconnects the antenna and connects the receiver input to J702-1. Connection to chassis ground is made at J702-4.



A310

RECEIVER ALIGNMENT

1. A 20-MHz signal source (GE IF Generator Model 4EX9A10 or equivalent) and a 406-470 MHz source connected to Antenna Switch J702 by Receiver Test Cable 19C317633G1.

2. GE Test Set Model 4EX3A10 or 4EX8K11 or voltmeter with equivalent sensitivity.

3. GE Test Amplifier Model 4EX16A10 and RF probe 19C311370G1, or equivalent RF voltmeter.

4. Distortion Analyzer or AC-VTVM.

PRELIMINARY CHECKS AND ADJUSTMENTS

1. In multi-frequency receivers where the maximum frequency spacing is less than one MHz, align the receiver of the Fl channel. Where the frequency spacing is more than one MHz, align the receiver on the center frequency.

2. Set the slugs in Z11/Z16 thru Z15/Z20 to the bottom of the coil form for frequencies in the low end of the band. Set the slugs near the top of the coil form for frequencies near the high end of the band.

3. Set the slug in RF AMP L3 to the top of the coil form for frequencies in the low end of the band, and near the bottom of the coil form for frequencies near the high end of the band.

4. Connect the negative lead of the DC Test Set to the Mult Test Point (H8), and the positive lead to ground. Connect the Distortion Analyzer or AC-VTVM across the speaker leads.

Step No.	Tuning Control	Procedure
1.	MULT L1	Adjust Ll for maximum meter reading.
2.	Z14/Z19 and Z15/Z20	Adjust $Z14/Z19$ and then $Z15/Z20$ for slight change in meter reading.
3.	Z11/Z16 thru Z13/Z18 and RF Amp L3	Apply an on-frequency signal to J702 and adjust Z11/Z16, Z12/Z17, Z13/Z18, and L3 for best quieting sensitivity.
4.	Mixer L2	Apply an on-frequency signal as above. With the RF probe on Pin 9 of IF Amp A304, tune L2 for maximum meter reading.
5.	MULT L1 Z14/Z19 and Z15/Z20	De-tune L1. Next, increase the on-frequency input signal and tune Z14/Z19 and Z15/Z20 for best quieting sensitivity. No re-adjust L1 for maximum meter reading.
		FREQUENCY ADJUSTMENT
6.		While applying an on-frequency signal to J702, loosely couple a 20-MHz signal to the Mixer. Adjust the Oscillator trimmer(s) for a zero beat frequency between the two signals. <u>Alternate Method</u> : Apply a strong 20 MHz signal to the Mixer. <u>Measure the output of the Discriminator with a DC-VTVM at</u> Pin 1 of A310. Note the reading. Next, remove the 20-MHz signal and apply a strong on-frequency signal to J702. Then tune the oscillator trimmer(s) for the meter reading obtained
		tune the oscillator trimmer(s) for the meter reading obtained at Pin 1 of A310.

ALIGNMENT PROCEDURE

ALIGNMENT PROCEDURE

406-470 MHz RECEIVER MODELS 4ER60A10-13

TEST PROCEDURES

These Test Procedures are designed to help you to service a receiver that is operat- refer to the "Service Check" listed to ing --- but not properly. The problems encountered could be low power, poor sensitivity. distortion. and low gain. By following the sequence of test steps starting with Step 1, the defect can be quickly localized.

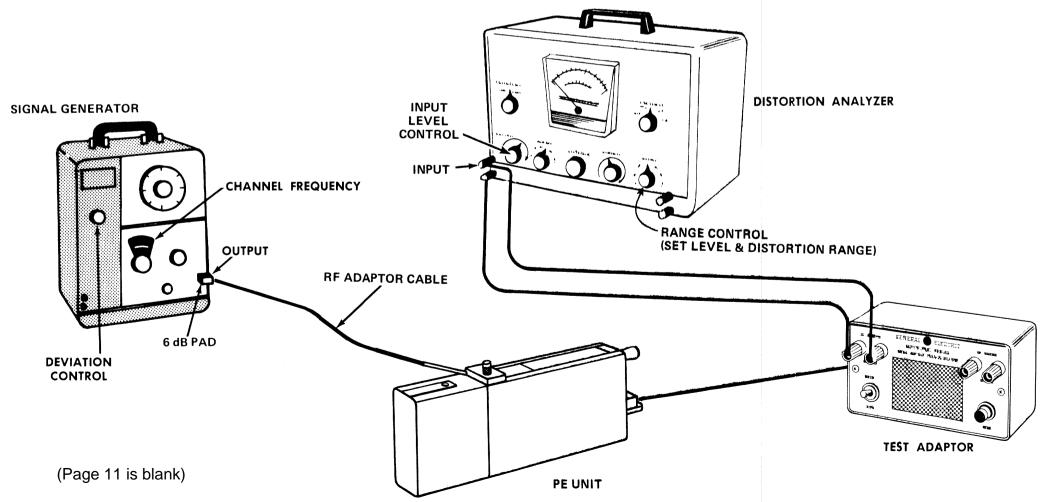
Once the defective stage is pin-pointed. correct the problem. Additional corrective measures are included in the Troubleshooting Procedure. Before starting with the Receiver Test Procedures, be sure the receiver is tuned and aligned to the proper operating frequency.

PRELIMINARY ADJUSTMENTS

TEST EQUIPMENT REQUIRED

- Distortion Analyzer similar to: Heath IM-12
- Signal Generator similar to: Measurements M-803
- 6-dB attenuation pad
- Test Adaptor Model 4EX12A10
- RF Adaptor Cable 19C317633G1

- 1. Connect the test equipment to the receiver as shown for all steps of the receiver Test Procedure.
- 2. Turn the SQUELCH control fully clockwise for all steps of the Test Procedure.
- 3. Turn on all of the equipment and let it warm up for 20 minutes.



AUDIO POWER OUTPUT AND DISTORTION TEST PROCEDURE

Measure Audio Power output as follows:

- A. Connect a 1,000-microvolt test signal modulated by 1,000 hertz ±3.0 kHz deviation to the Antenna Switch J702.
- B. Set the Volume Control for a 500 milliwatt output (2 volts RMS).
- C. Make distortion measurements according to manufacturer's instructions. Reading should be less than 5%-10% (5% is typical). If the receiver sensitivity is to be measured, leave all controls and equipment as they are.

SERVICE CHECK

If the distortion is more than 5%, or maximum audio output is less than 0.5 watt. make the following checks:

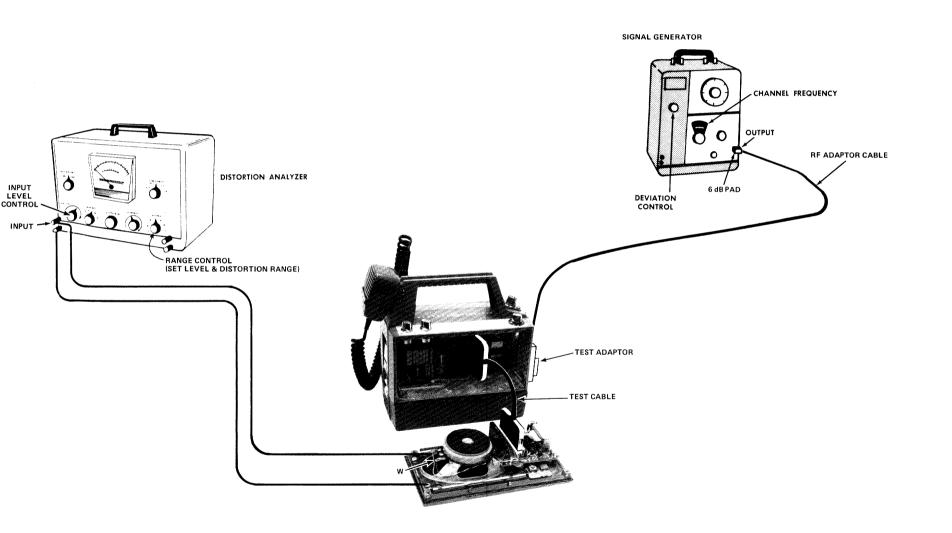
- D. Battery voltage---low voltage will cause distortion. (Refer to Receiver Schematic Diagram for voltages.)
- E. Audio Gain (Refer to Receiver Troubleshooting Procedure)

USABLE SENSITIVITY (12 dB SINAD)

TEST PROCEDURE

If STEP 1 checks out properly, measure the receiver sensitivity as follows:

- A. Apply a 1000-microvolt, on-frequency signal modulated by 1000 Hz with 3.0-kHz deviation to J702.
- B. Place the RANGE switch on the Distortion Analyzer in the 200 to 2000-Hz distortion range position (1000-Hz filter in the circuit). Tune the filter for minimum reading or null on the lowest possible scale (100%, 30%, etc.)
- C. Place the RANGE switch to the SET LEVEL position (filter out of the circuit) and adjust the input LEVEL control for a +2 dB reading on a mid range (30%).
- D. While reducing the signal generator output, switch the RANGE control from SET LEVEL to the distortion range until a 12-dB difference (+2 dB to -10 dB) is obtained between the SET LEVEL and distortion range positions (filter out and filter in).



STEP 1

STEP 2

- E. The 12-dB difference (Signal plus Noise and Distortion to noise plus distortion ratio) is the "usable" sensitivity level. The sensitivity should be less than rated 12 dB SINAD specification with an audio output of at least 250 milliwatts.
- F. Leave all controls as they are and all equipment connected if the Modulation Acceptance Bandwidth test is to be performed.

SERVICE CHECK

If the sensitivity level is more than rated 12 dB SINAD, check the alignment of the RF stages as directed in the Alignment Procedure, and make the gain measurements as shown on the Troubleshooting Procedure.

STEP 3

MODULATION ACCEPTANCE BANDWIDTH (IF BANDWIDTH)

TEST PROCEDURE

If STEPS 1 and 2 check out properly measure the bandwidth as follows:

- A. Set the Signal Generator output for twice the microvolt reading obtained in the 12-dB SINAD measurement.
- B. Set the RANGE control on the Distortion Analyzer in the SET LEVEL position (1000-Hz filter out of the circuit), and adjust the input LEVEL control for a +2 dB reading on the 30% range.
- C. While increasing the deviation of the Signal Generator, switch the RANGE control from SET LEVEL to distortion range until a 12-dB difference is obtained between the SET LEVEL and distortion range readings (from +2 dB to -10 dB).
- D. The deviation control reading for the 12-dB difference is the Modulation Acceptance Bandwidth of the receiver. It should be more than ± 7 kHz (but less than ± 9 kHz).

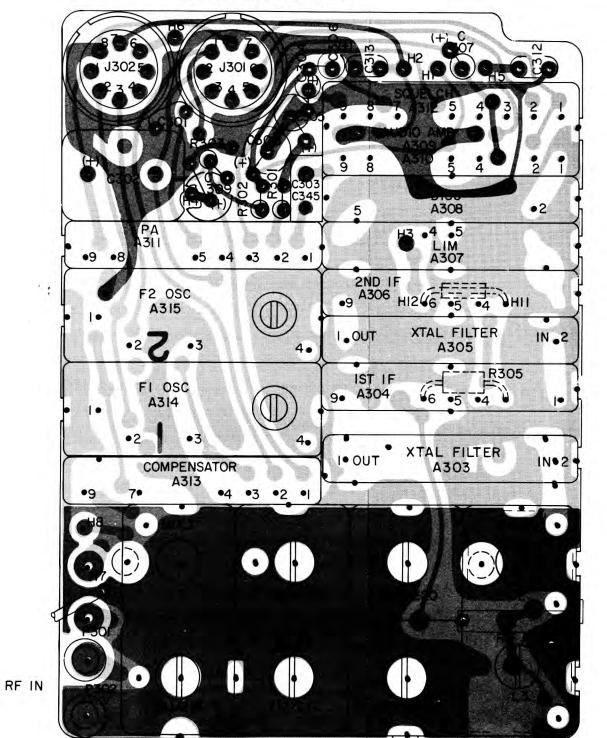
SERVICE CHECK

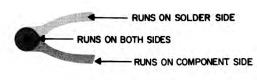
If the Modulation Acceptance Bandwidth test does not indicate the proper width, make gain measurements as shown on the Receiver Troubleshooting Procedure.

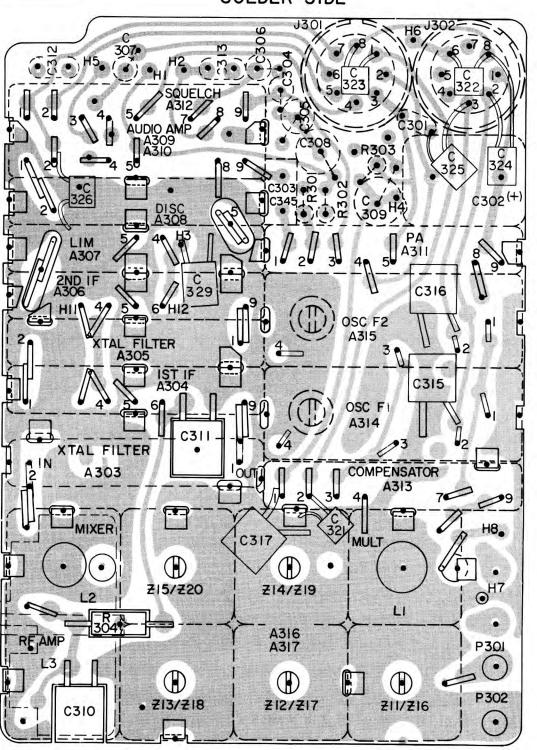
LBI-4638

	PIN I	PIN 2	PIN 3	PIN 4	PIN 5	PIN 6	PIN 7	PIN 8
J30I	5.4V	AUDIO OUT	SWITCHED 7.5V	SQ ARM	VOL ARM	SQ HI	VOL HI	GND
J302		FREQ I	FREQ 2			7.5V	TONE SWITCH	GND

COMPONENT SIDE







OUTLINE DIAGRAM

406-470 MHz RECEIVER MODELS 4ER60A10-13

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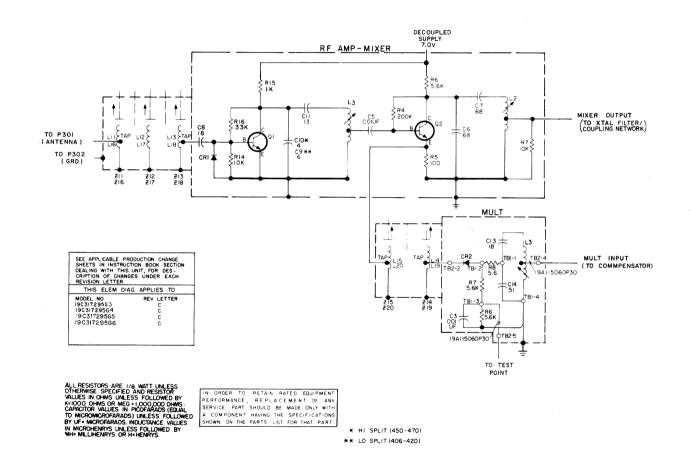
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SOLDER SIDE

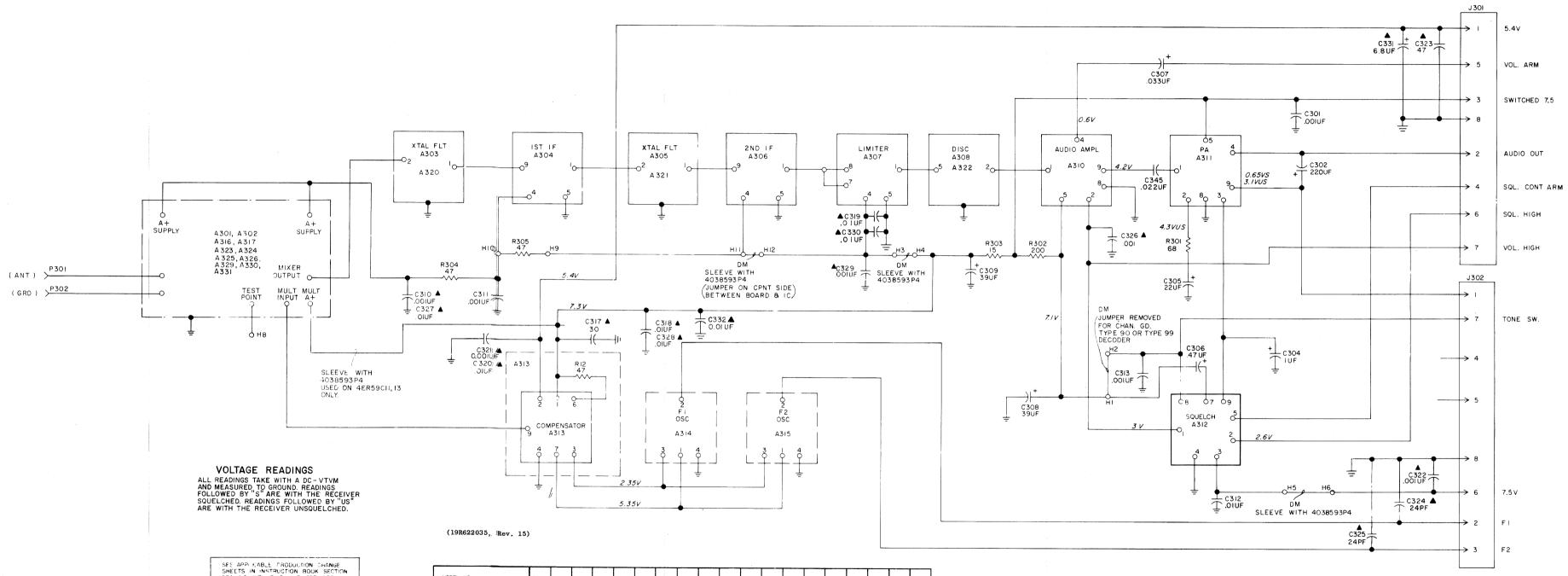
(19D416913, Rev. 8) (19D416852, Sh. 2, Rev. 5)



(19C320887, Rev. 5)

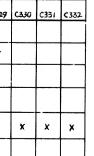
SCHEMATIC DIAGRAM

406-470 MHz RECEIVER FRONT END (A316/317) MODELS 4ER60A10-13



SEE APPLICABLE CROU SHEETS IN INSTRUCTION DEALING WITH THIS U CRIPTION OF CHANGET REVISION LETTER	ON BOOK SECTION
THIS ELEM DIAG	APPLIES TO
MODEL NO	REV LETTER
PLI9D417490GI	н
PLI9D417490G2	G
PLI9D417490G3	G
PL19A130042G1	А
PL19A130042G2	Α
PLI9A130042G3	А
P_19A130042G4	A
PL19A130042G5	<u>م</u>
PLI9A15004266	<u> </u>

MODEL NO.	C3 10	C315	C316	C317	C318	C319	C320	C321	C322	C323	C324	C325	C326	C327	C 328	C319
4ER59A10-13 (KIT PL19A1300342G1)	x								1				x			
4ER60A10-13 (KIT PLI9AI300442G2)	×			×	1			x	×	×	×	x	x			×
4ER6IAII- 13 - 15 - 17 (KIT PLI9A3004263)					1	x	x						x	×	x	
4ER62AIO-II (KIT PLI9AI300%264)	×			x	×		×						x			
4ER59C11,13 (KIT PL19A1300/42G5)	×					x		x					x		x	
4ER87A10-133 (KIT PL19A130042G6)	·					x	×						×	×	x	





IN ORDER TO RETAIN RATED EQUIPMENT PERFORMANCE, REPLACEMENT OF ANY SERVICE PART SHOULD BE MADE ONLY WITH A COMPONENT HAVING THE SPECIFICATIONS SHOWN ON THE PARTS LIST FOR THAT PART. ALL RESISTORS ARE 1/8 WATT UNLESS OTHERWISE SPECIFIED AND RESISTOR VALUES IN OHMS UNLESS FOLLOWED BY K=1000 OHMS OR MEG=1.000,000 OHMS. CAPACITOR VALUES IN PICOFARADS (EQUAL TO MICROMICROFARADS, INDUCTANCE VALUES BY UF= MICROFARADS, INDUCTANCE VALUES IN MICROHENRYS UNLESS FOLLOWED BY MH= MILLIHENRYS OR H=HENRYS.

SCHEMATIC DIAGRAM

406-470 MHz RECEIVER MODELS 4ER60A10-13

-4638		PARTS LIST	SYMBOL	. GE PART NO.	DESCRIPTION	SYMBOL	GE PART NO.	DESCRIPTION	SYMBOL	GE PART NO.	DESCRIPTION	SYMBOL	ge part no.	DESCRIPTION	SYMBOL	GE PART NO.	DESCRIPTION
		LBI-4381F 406-470 MHz RECEIVER REGOA10 406-420 MHz			INDUCTORS			HELICAL RESONATORS				A313*	19C320061G1	Compensator.			
	41	R60All 450-470 MHz R60Al2 406-420 MHz CG	L2	19B216948G1	Coil.	Z11		Consists of Lll and 19D413132P24 can.	L11	19B216439G8	Helical resonator. (Part of Zll). Includes:			In REV B and earlier:	to an American		CAPACITOR KIT 19A130042G2
	48	R60A13 450-470 MHz CG	L3	19A128005G1	Coil. Includes:	Z12		Consists of L12 and 19D413132P3 can.		19C311750P1	Tuning slug.		19C311891G5	Compensator.			
				19B209436P1	Tuning slug.	Z13		Consists of L13 and 19D413132P3 can.	L12	19B216439G6	Helical resonator. (Part of Z12). Includes:				C310	E 405 200 P1 0	CAPACITORS
						Z14		Consists of L14 and 19D413132P19 can.		19C311750P1	Tuning slug.			OSCILLATORS	C310 C315*	5495323P12	Ceramic: .001 µf +100% ~20%, 75 VDCW.
SYMBOL	GE PART NO.	DESCRIPTION			TRANSISTORS	Z15		Consists of L15 and 19D413132P20 can.	L13	19B216439G19	Helical resonator. (Part of Z13). Includes:	A314		NOTE: When reordering, give GE Part Number	and C316*	5495323P12	Ceramic: .001 µf +100% -20%, 75 VDCW. Deleted by REV A.
			Q1 and	19A116159P1	Silicon, NPN.	Z16		Consists of L16 and 19D413132P24 can.		19C311750P1	Tuning slug.	and A315	12000110	and specify exact frequency needed.	C317	19A116114P7045	
A316*		FRONT END	Q2			Z17		Consists of L17 and 19D413132P3 can.	L14	19B216439G4	Helical resonator. (Part of Z14). Includes:		4EG28A12	Oscillator Module. 406-420 MHz. $Fx = \frac{Fo + 20}{21}$	C321	5495323P12	Ceramic: 30 pf $\pm 5\%$, 100 VDCW; temp coef -750 pPM
and A317*		19C317295G5 406-420 MHz 19C317295G6 450-470 MHz	R4	2016100041		Z18		Consists of L18 and 19D413132P25 can.		19C311750P1	Tuning slug.		4EG28A13	Oscillator Module. 450-470 MHz. $Fx = \frac{FO - 20}{21}$	and C322	0400023712	Ceramic: .001 µf +100% -20%, 75 VDCW.
		(Added by REV A)	R4 R5	3R151P204J 3R151P101J	Composition: 0.20 megohm $\pm 5\%$, 1/8 w.	Z19		Consists of L19 and 19D413132P19 can.	L15	19B216439G3	Helical resonator. (Part of Z15). Includes:				C323	19A116114P8053	Ceramic: 47 pf ±5%, 100 VDCW; temp coef
A5* and		RF AMPLIFIER A5 19C327300G3 406-450 MHz	R6	3R151P562J	Composition: 100 ohms $\pm 5\%$, 1/8 w. Composition: 5600 ohms $\pm 5\%$, 1/8 w.	Z20		Consists of L20 and 19D413132P20 can.		19C311750P1	Tuning slug.			CAPACITORS			-1500 PPM.
A6*		A6 19C327300G4 450-470 MHz (Added by REV C)	R7	3R151P103J	Composition: 10,000 ohms ±5%, 1/8 w.				L16	19B216439G7	Helical resonator. (Part of Z16). Includes:	C301	5495323P12	Ceramic: .001 μf +100% -20%, 75 VDCW.	C324 and	19A116114P2042	Ceramic: 24 pf ±5%, 100 VDCW; temp coef -80 PPM.
		(Added by REV ()	R14	3R151P103J	Composition: 10,000 ohms ±5%, 1/8 w.	A316* and		FRONT END 19C317295G3 406-420 MHz		19C311750P1	Tuning slug.	C302	19A116178P7	Tantalum: 220 μ f ±20%, 6 VDCW.	C325		00 AAN .
		CAPACITORS	R14	3R151P1035	Composition: 1000 ohms ±5%, 1/8 w.	A317*		19C317295G4 450-470 MHz (Deleted by REV A)	L17	19B216439G2	Helical resonator. (Part of Z17). Includes:	C303*	19A116089P1	Ceramic: 0.1 μ f ±20%, 50 VDCW, temp range -55 to +85°C. Deleted by REV H.	C326	5495323P12	Ceramic: .001 µf +100% -20%, 75 VDCW.
C5	5495323P12	Ceramic: .001 µf +100% -20%, 75 VDCW.	R16	3R151P333J	Composition: 33,000 ohms ±5%, 1/8 w.					19C311750P1	Tuning slug.	C304	5491674P28	Tantalum: 1.0 μ f $\pm 20\%$, 25 VDCW; sim to	C329	5495323P12	Ceramic: .001 μf +100% -20%, 75 VDCW.
C6 and	19A116114P4059	Ceramic: 68 pf $\pm 5\%$, 100 VDCW; temp coef -220 PPM.	110	5815175550	Composition, 50,000 0tmms 10%, 1/8 W.	A5 and		RF AMPLIFIER A5 19C317445G3	L18	19B216439G1	Helical resonator. (Part of Z18). Includes:			Sprague Type 162D.			
C7			A10		MULTIPLIER 19C311873G7	A6		A6 19C317445G4		19C311750P1	Tuning slug.	C305	5491674P35	Tantalum: 22 μ f ±20%, 4 VDCW; sim to Sprague Type 162D.			
C8	19A116114P6038	Ceramic: 18 pf $\pm 5\%$, 100 VDCW; temp coef -470 PPM.			10001101001			CAPACITORS	L19	19B216439G4	Helical resonator. (Part of Z19). Includes:	C306	5491674P27	Tantalum: .47 μf ±20%, 35 VDCW; sim to			
С9	19A116114P2020	Ceramic: 6 pf ±5%, 100 VDCW; temp coef -80 PPM.			CAPACITORS	C5	5495323P12	Ceramic: .001 µf +100% -20%, 75 VDCW.		19C311750P1	Tuning slug.			Sprague Type 162D.			
C10	19A116114P2014	Ceramic: 4 pf $\pm 5\%$, 100 VDCW; temp coef -80 PPM.	С3	5495323P12	Ceramic: .001 μ f +100% -20%, 75 VDCW.	C6	19A116114P4059	Ceramic: 68 pf $\pm 5\%$, 100 VDCW; temp coef	L20	19B216439G3	Helical resonator. (Part of Z20). Includes:	C307	5491674P31	Tantalum: .033 μ f \pm 20%, 35 VDCW; sim to Sprague Type 162D.	and a second		
C11	19A116114P2035	Ceramic: 13 pf $\pm 5\%$, 100 VDCW; temp coef -80 PPM.	C13	19A116114P2038	Ceramic: 18 pf $\pm 5\%$, 100 VDCW; temp coef -80 PPM.	and C7		-220 PPM.		19C311750P1	Tuning slug.	C308	5491674P30	Tantalum: 39 μ f ±20%, 10 VDCW; sim to			
		DIODES AND RECTIFIERS	C14	19A116114P2054	Ceramic: 51 pf $\pm 5\%$, 100 VDCW; temp coef -80 PPM.	C8	19A116114P6038	Ceramic: 18 pf $\pm 5\%$, 100 VDCW; temp coef -470 PPM.			HELICAL RESONATORS	and C309		Sprague Type 162D.			
CR1*	19A116052P1	Silicon. Added by REV B.			DIODES AND RECTIFIERS	С9	19A116114P2020	Ceramic: 6 pf $\pm 5\%$, 100 VDCW; temp coef -80 PPM.	Z11		Consists of Lll and 19D413132P24 can.	C311	5495323P12	Ceramic: .001 µf +100% -20%, 75 VDCW.	AC TRADUCT		
			CR2	19A116809P1	Silicon.	C10	19A116114P2014	Ceramic: 4 pf $\pm 5\%$, 100 VDCW; temp coef -80 PPM.	Z12		Consists of L12 and 19D413132P3 can.	C312*	19A116192P1	Ceramic: 0.01 μ f ±20%, 50 VDCW; sim to Erie			
		INDUCTORS			INDUCTORS	C11	19A116114P2035	Ceramic: 13 pf $\pm 5\%$, 100 VDCW; temp coef -80 PPM.	Z13		Consists of L13 and 19D413132P25 can.			8121 SPECIAL.	Careeren		
L2	19B216948G1	Coil.	L3	19B216296P3	Coil.				Z14		Consists of L14 and 19D413132P19 can.			In REV A and earlier:			
L3	19A128005G1	Coil. Includes:				L2	19B216948G1	Coil.	Z15		Consists of L15 and 19D413132P20 can.		5495323P12	Ceramic: .001 µf +100% -20%, 75 VDCW.	an ve alla service.		
	19B209436P1	Tuning slug.	R6*	3R151P562J	Composition: 5600 ohms $\pm 5\%$, $1/8$ w. Deleted by	L2 L3	19A128005G1	Coil. Includes:	Z16		Consists of L16 and 19D413132P24 can.	C313	5495323P12	Ceramic: .001 µf +100% -20%, 75 VDCW.	4 (party may		
		TRANSISTORS			REV A.	5	19B209436P1	Tuning slug.	Z17		Consists of L17 and 19D413132P3 can.	C314*	5495323P12	Ceramic: .001 μf +100% -20%, 75 VDCW. Deleted by REV E.	and from the		
Q1	19A116159P1	Silicon, NPN.	R7	3R151P562J	Composition: 5600 ohms $\pm 5\%$, $1/8$ w.		19820943071	Tuning Stug.	Z18		Conssts of L18 and 19D413132P25 can.	C345*	19A116192P6	Ceramic: 0.022 μ f ±20%, 50 VDCW; sim to Erie			
and Q2			R8	3R151P5R6J	Composition: 5.6 ohms $\pm 5\%$, $1/8$ w.			TRANSISTORS	Z19		Consists of L19 and 19D413132P19 can.			8131-M050-W5R-223M. Added by REV H.			
		RESISTORS	R10*	3R151P562J	Composition: 5600 ohms $\pm 5\%$, 1/8 w. Added by REV A.	Q1 and	19A116159P1	Silicon, NPN.	Z20		Consists of L20 and 19D413132P20 can.			JACKS AND RECEPTACLES			
R4	3R151P204J	Composition: 0.20 megohm $\pm 5\%$, 1/8 w.				Q2						J301	19A116122P1	Feed-thru: sim to Warren Co 1-B-2994-4.			
R5	3R151P101J	Composition: 100 ohms $\pm 5\%$, $1/8$ w.						RESISTORS			RECEIVER BOARD 19D417490G1	and J302			- Ni washadan W		
R6	3R151P562J	Composition: 5600 ohms $\pm 5\%$, $1/8$ w.		19B200497P5	Tuning slug. (Used with L3).	Rl	3R151P184J	Composition: 0.18 megohm $\pm 5\%$, 1/8 w.	A303*	19C304824G1	Crystal Filter.			PLUGS			
R7	3R151P103J	Composition: 10,000 ohms $\pm 5\%$, 1/8 w.				R2	3R151P302J	Composition: 3000 ohms $\pm 5\%$, $1/8$ w.	A303#	19090402401	In REV C and earlier:	P301 and	19A115834P4	Contact, electrical: sim to AMP 2-332070-9.	an a		
R14	3R151P103J	Composition: 10,000 ohms $\pm 5\%$, 1/8 w.	L11	19B216439G8	Helical resonator. (Part of Z11). Includes:	R4	3R151P204J	Composition: 0.20 megohm $\pm 5\%$, 1/8 w.		19C304516G3	Crystal Filter.	P302					
R15	3R151P102J	Composition: 1000 ohms $\pm 5\%$, 1/8 w.		19C311750P1	Tuning slug.	R5	3R151P101J	Composition: 100 ohms ±5%, 1/8 w.		10000101040				RESISTORS			
R16	3R151P333J	Composition: 33,000 ohms $\pm 5\%$, 1/8 w.	L12	19B216439G6	Helical resonator. (Part of Z12). Includes:	R6	3R151P562J	Composition: 5600 ohms $\pm 5\%$, $1/8$ w.	A304	19C311879G3	lst IF Amplifier.	R301*	3R151P680J	Composition: 68 ohms $\pm 5\%$, $1/8$ w.			
A5 *		RF AMPLIFIER		19C311750P1	Tuning slug.	R7	3R151P103J	Composition: 10,000 ohms $\pm 5\%$, 1/8 w.	A305*	19C304824G1	Crystal Filter.			In REV A-D:			
and A6*		A5 19C317445G3 406-450 MHz A6 19C317445G4 450-470 MHz	L13	19B216439G19	Helical resonator. (Part of Z13). Includes:	A7		MULTIPLIER			In REV A and earlier:		3R151P101J	Composition: 100 ohms $\pm 5\%$, 1/8 w.			
		(Deleted by REV C)		19C311750P1	Tuning slug.			19C311873G6		19C304508G3	Crystal Filter.			Earlier than REV A:	an a		
		CAPACITORS	L14	19B216439G4	Helical resonator. (Part of 214). Includes:			CAPACITORS					3R151P470J	Composition: 47 ohms $\pm 5\%$, $1/8$ w.			
C5	5495323P12	Ceramic: .001 µf +100% -20%, 75 VDCW.		19C311750P1	Tuning slug.	СЗ	5495323P12	Ceramic: .001 µf +100% -20%, 75 VDCW.	A306	19C311879G4	2nd IF Amplifier.	R302	3R151P201J	Composition: 200 ohms $\pm 5\%$, $1/8$ w.			
C6	19A116114P4059	Ceramic: 68 pf ±5%, 100 VDCW; temp coef -220 PPM.	L15	19B216439G3	Helical resonator. (Part of Z15). Includes:	C4	19A116114P2050	Ceramic: 39 pf $\pm 5\%$, 100 VDCW; temp coef -80 PPM.	A307	19C311876G4	Limiter.	R303	3R151P150J	Composition: 15 ohms $\pm 5\%$, 1/8 w.			
and C7				19C311750P1	Tuning slug.	C5	19A116114P7065	Ceramic: 100 pf $\pm 5\%$, 100 VDCW; temp coef -750 PPM.	1.			R304 and	3R151P470J	Composition: 47 ohms $\pm 5\%$, $1/8$ w.			
C8	19A116114P6038	Ceramic: 18 pf ±5%, 100 VDCW; temp coef -470 PPM.	L16	19B216439G7	Helical resonator. (Part of Z16). Includes:				A308	19C304504G3	Discriminator.	R305			and the second se		
С9	19A116114 P2 020	Ceramic: 6 pf $\pm 5\%$, 100 VDCW; temp coef -80 PPM.		19C311750P1	Tuning slug.			DIODES AND RECTIFIERS	A309*	19C311878G2	Audio Amplifier. Deleted by REV H.			MISCELLANEOUS			
C10	19A116114P2014	Ceramic: 4 pf $\pm 5\%$, 100 VDCW; temp coef -80 PPM.	L17	19B216439G2	Helical resonator. (Part of Z17). Includes:	CR1	19A116081P1	Silicon.		100011005			19A129132P1	Shield. (Used with A5-A7).			
C11	19A116114P2035	Ceramic: 13 pf $\pm 5\%$, 100 VDCW; temp coef -80 PPM.		19C311750P1	Tuning slug.			INDUCTORS	A310*	19C311995G4	Audio Amplifier.		19B216316P1	Insulator. (Used with J301 and J302).			
		DIODES AND RECTIFIERS	L18	19B216439G1	Helical resonator. (Part of Z18). Includes:	Ll	19B216296P1	Coil.		10021100500	In REV G and earlier:						
CR1*	19A116052P1			19C311750P1	Tuning slug.	1			1	19C311995G2	Audio Amplifier. (Includes Tone Filter).						
	10011000221	Silicon. Added by REV B.	L19	19B216439G4	Helical resonator. (Part of Z19). Includes:			RESISTORS	A311*	19C311877G3	PA.						
				19C311750P1	Tuning slug.	R1 and	3R151P432J	Composition: 4300 ohms $\pm 5\%$, $1/8$ w.			In REV F and earlier:						
			L20	19B216439G3	Helical resonator. (Part of Z20). Includes:	R2				19C311877G2	PA.						
				19C311750P1	Tuning slug.			MISCELLANEOUS	A312	19C311880G4	Squelch.						
							19B200497P5	Tuning slug.	n312	19031100004	oqueien,						
1				1		1	1					1					

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PRODUCTION CHANGES

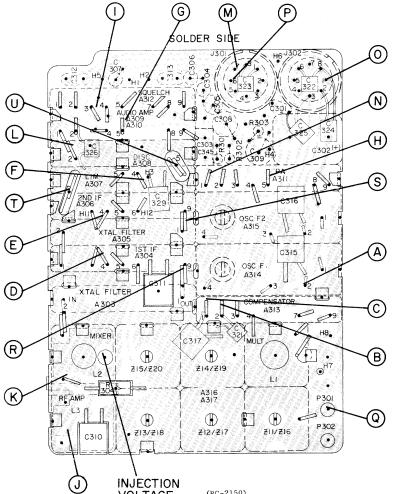
Changes in the equipment to improve performance or to simplify circuits are identified by a "Revision Letter", which is stamped after the model number of the unit. The revision stamped on the unit includes all pre-vious revisions. Refer to the Parts List for descriptions of parts affected by these revisions.

REV. A -	- <u>4ER60A10-13</u> To improve design. Changed A316 and A317.
REV. B -	- To improve squelch action. Changed A305.
REV. C -	- To suppress harmonics from IF limiter. Added C329.
REV. A -	- <u>Receiver Board 19D417490G1</u> To increase audio sensitivity. Changed R3C1.
REV. A -	- Receiver Front End 19C317295G5 & 6 To improve receiver spurious response. Deleted R2 and R6. Added shield.
REV B -	Receiver Board 19D417490G1
	To improve critical squelch operation. Changed C312.
REV. C -	- To eliminate spurious when keyed. Changed A313.
REV B	Possivon Event End 10001500505 a
	Receiver Front End 19C317295G5 & 6 To add base protection for transistor Q1. Added CR1.
REV. C -	To improve ease of assembly, troubleshooting and repair. Changed A5 and A6.
REV. D -	Receiver Board 19D417490G1
	To improve factory producibility. Changed A303.
REV. E -	To improve audio sensitivity and stability. Deleted C314 and changed R301.
REV. F -	To improve audio frequency response and attack time. Add C345 to be used with Channel Guard.
	To improve audio quality. Changed A311.
REV. H -	To eliminate Non-Channel Guard receiver boards, Deleted callout of $\blacksquare A309$ and circle (\bullet) in front of A310. Deleted callout of $\blacksquare C303$ and circle (\bullet) for C345.
	Deleted Notes: \blacksquare Use for Non-Channel Guard receivers and \bullet use for Channel Guard receivers.
	Schematic Diagram Was:
	0.6V
	AUDIO AMPL ■A309 ■A309
	A300 = -4.2V IUF A310 = -4.2V (
	\circ

REV. A - <u>Receiver Kit 19A130042G2</u> To improve reliability. Deleted C315 and C316.

QUICK CHECKS

SYMPTOM	PROCEDURE
No Audio	 Check audio waveform at the top of the Volume Control (see Step 2).
	 If audio is present, check voltage readings of Audio and Squelch modules (see Schematic Diagram).
	 If audio is not present, check gain and current readings of Front End and IF modules (see Steps 1 & 3).
Poor Sensitivity	 Measure the gain of the Mixer stage (see Step 3). If low, measure the gain of the RF amplifier and IF modules.
Improper Squelch Operation	1. Check the noise waveform at the input to the Squelch module and at Squelch Con- trol high (see Step 2).
	 Measure the DC voltages for the Squelch module (squelched and unsquelched).



INJECTION VOLTAGE TEST POINT (RC-2150) (19D416913, Rev. 8) (19D416852, Sh. 2, Rev. 5)

STEP 3 - RF GAIN CHECKS

EQUIPMENT REQUIRED:

- RF probe and Test Amplifier Model 4EX16A10 connected to GE Test Set Model 4EX3A10, or an RF voltmeter.
- A signal generator (M-800 or equivalent) connected to P301 (High) and P302 (Low).

PROCEDURE FOR MIXER & 1ST IF:

- Switch the Test Set to the Test 1 position and the Test Amplifier to the X50 position.
- 2. Connect the RF probe across the input of the stage to be measured as shown on the diagram. Increase the signal generator output to obtain a reference reading on Test Set 4EX3A10. Note the Test Set reading and the dB reading on the generator (dB1).
- 3. Connect the RF probe to the output of the stage to be measured as shown on the diagram. Decrease the generator output until the Test Set reference reading in Step 2 is obtained. Note the dB reading on the generator (dB2).
- 4. Subtract the dBl reading from the dB2 reading and check the results with the typical gains shown on the diagram.

	35	dB	(dB2)	
Example:			(dBl)	
	20	dB	gain	

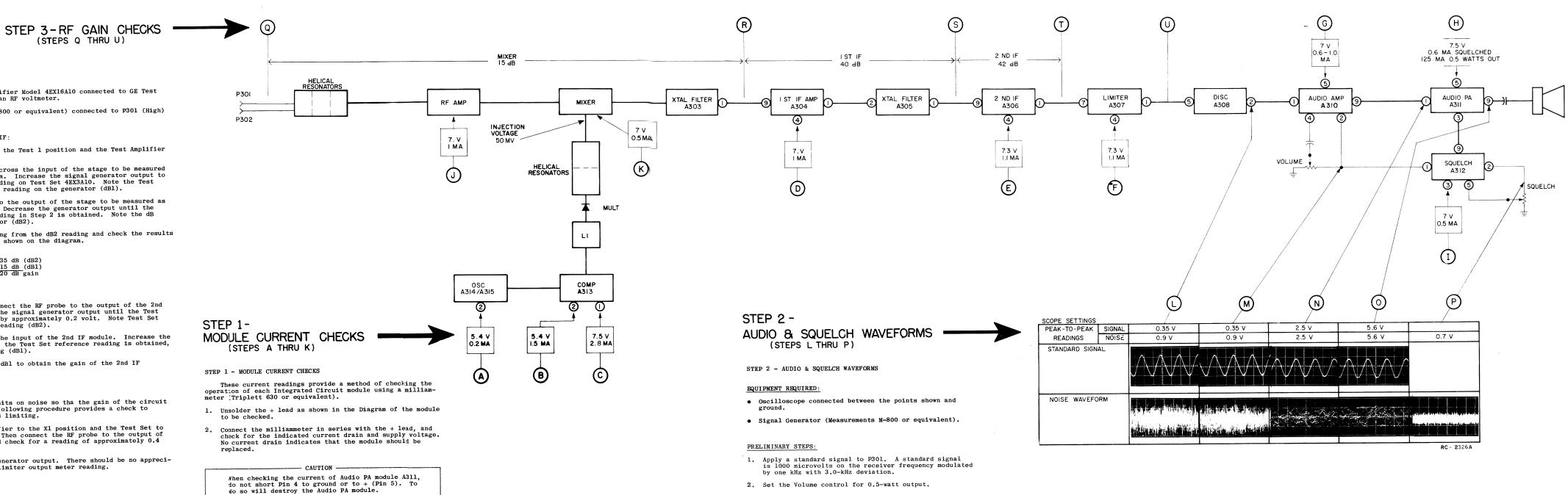
PROCEDURE FOR 2ND IF:

- 1. With no signal in, connect the RF probe to the output of the 2nd IF module. Increase the signal generator output until the Test Set reading increases by approximately 0.2 volt. Note Test Set and signal generator reading (dB2).
- Connect the probe to the input of the 2nd IF module. Increase the signal generator until the Test Set reference reading is obtained, and note the dB reading (dB1).
- 3. Now subtract dB2 from dB1 to obtain the gain of the 2nd IF amplifier module.

LIMITER CHECK

The Limiter module limits on noise so tha the gain of the circuit cannot be measured. The following procedure provides a check to determine if the module is limiting.

- 1. Switch the Test Amplifier to the XI position and the Test Set to the Test 1 position. Then connect the RF probe to the output of the Limiter module and check for a reading of approximately 0.4 volt.
- Increase the signal generator output. There should be no appreci-able increase in the limiter output meter reading.



TROUBLESHOOTING PROCEDURE

406-470 MHz RECEIVER MODELS 4ER60A10-13

Issue 5

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END OF DOCUMENT